Also published as:

EP1313218 (A)

US6919777 (B:

US2003058066

② JP2002141771 ② CN1196258C (

Cited documents:

JP5183380

JP2001160731

## Original document

# SURFACE ACOUSTIC WAVE FILTER DEVICE

Patent number:

WO0217483

Publication date:

2002-02-28

Inventor:

TANIGUCHI NORIO (JP); TAKATA TOSHIAKI (JP);

TAKEDA MITSUO (JP)

Applicant:

MURATA MANUFACTURING CO (JP); TANIGUCHI

NORIO (JP); TAKATA TOSHIAKI (JP); TAKEDA

MITSUO (JP)

Classification:

- international:

H03H9/05; H03H9/64; H03H9/00; H03H9/05; (IPC1-

7): H03H9/25

- european:

Application number: WO2001JP07042 20010815

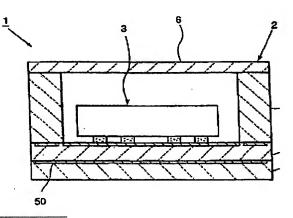
Priority number(s): JP20000249954 20000821; JP20010225768 20010726

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#### Abstract of WO0217483

A surface acoustic wave filter device, comprising a surface acoustic filter element having a ladder type circuit electrically connected and mechanically fixed to a package by a face down work method, wherein a micro strip line connected to a series arm resonator and/or a parallel arm resonator is provided inside the package, whereby excellent filter characteristics can be provided by the addition of the inductance component thereof.



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Description of corresponding document: US2003058066

# BACKGROUND OF THE INVENTION

[0001] 1. Field of the Invention

[0002] The present invention relates to a surface acoustic wave filter, and more particularly, to a surface acoustic wave filter device including a ladder type circuit.

[0003] 2. Description of the Related Art

[0004] A conventional band-pass filter includes a ladder type circuit having a plurality of one termin surface acoustic wave resonators that are connected in a ladder configuration (e.g., Japanese Unexan Patent Application Publication No. 05-183380).

[0005] In this band-pass filter, a plurality of one terminal pair surface acoustic wave resonators are connected in series between an input terminal and an output terminal as series arm resonators to defi series arms. In addition, a plurality of one terminal pair surface acoustic wave resonators are connect parallel between the series arms and ground as parallel arm resonators to define parallel arms.

[0006] The band-pass filter including a ladder type circuit has reduced insertion loss and a wide pass and is commonly used as a band-pass filter in a portable telephone.

[0007] Japanese Unexamined Patent Application Publication No. 05-183380 discloses that an induct component is connected in series to the above-described series arm resonator or parallel arm resonat this provides an increased bandwidth.

[0008] Also, Japanese Unexamined Patent Application Publication No. 10-93382 discloses a structure wherein an inductance is added to parallel arm resonators in a surface acoustic wave filter device ha ladder type circuit. FIG. 18 shows a circuit configuration of the surface acoustic wave filter device according to this prior art. In the surface acoustic wave filter device 501, series arm resonators S1 an and parallel arm resonators P1 to P3 are connected to one another so as to define a ladder type circui Here, an inductance L is inserted between the parallel arm resonators P1 to P3 and the ground potent thereby provide an increased pass band width and an increased attenuation value in the vicinity of a

[0009] On the other hand, Japanese Unexamined Patent Application Publication No. 04-65909 disclo structure in which a surface acoustic wave filter element is connected to a package by a face down mounting process. Conventionally, in the package in which the surface acoustic wave filter element accommodated, the electrodes of a package and the electrodes of the surface acoustic wave filter electrodes of the surf are connected by bonding wires. In contrast, the surface acoustic wave filter device disclosed in this art has a reduced size by utilizing the face down mounting process. FIG. 19 shows a schematic section view of a package of a surface acoustic wave filter element provided using this face down mounting process.

[0010] In the surface acoustic wave filter device 601, a surface acoustic wave filter element 603 is provided in a package 602. The package 602 includes a base board 602a, a side wall 602b, and a cap [0011] On the base board 602a, a die-attach portion 602d is provided having a plurality of electrode electrically connected to the surface acoustic wave filter element 603. The surface acoustic wave filt element 603 includes a piezoelectric substrate 603a, and electrodes of a surface acoustic wave filter element are provided on the bottom surface of the piezoelectric substrate 603a. The electrodes provided on the bottom surface of the piezoelectric substrate 603a. the bottom surface of the piezoelectric substrate 603a are electrically connected to the electrode pads die-attach portion 602d via bumps 604, and the surface acoustic wave filter element 603 is mechanic fixed to the die-attach portion 602d via the bumps 604.

[0012] In a face down mounting method for bonding, a surface including electrodes defining a surface acoustic wave filter element of the piezoelectric substrate is attached to a package by bumps. Since r bonding wires are required, a surface acoustic wave filter device having a reduced size is produced. [0013] As disclosed in the Japanese Unexamined Patent Application Publications Nos. 05-183380 au 93382, when an inductance is added to a series arm resonator or a parallel arm resonator in a surface acoustic wave filter device having a ladder type circuit, the filter characteristics thereof are improved Also, when connecting a surface acoustic wave filter element and the electrodes on a package by a b wire, the above-described inductance can be included using the bonding wire.

[0014] However, in the surface acoustic wave filter device 601, which is packaged by above-describ face down mounting process, since no bonding wires are provided, an inductance component cannot added to the surface acoustic wave filter device 601 using the bonding wire. A small inductance component may be provided by rooting electrodes connecting the external electrodes provided on the package to the die-attach portion, but a large inductance cannot be obtained by such rooting electrod [0015] Therefore, in the surface acoustic wave filter device disclosed in the Japanese Unexamined P Application Publication No. 04-65909, it is difficult to achieve an increased pass band width and an increased attenuation value in the vicinity of a pass band, by the addition of inductance.

[0016] Japanese Unexamined Patent Application Publication No. 04-65909 describes that, by adding inductance components between each of the input/output signal terminals and the ground terminal in package, an input/output impedance matching is achieved without using external elements. This description, however, applies to a surface acoustic wave filter having a structure which must achieve input/output impedance matching outside the surface acoustic wave filter. Accordingly, in the case of surface acoustic wave filter having a ladder circuit configuration which does not need to be matched unnecessary to achieve an impedance matching between each of the input/output signal terminals an ground terminal in such a package.

[0017] Also, in the Japanese Unexamined Patent Application Publication No. 04-65909, inductance components are provided in the die-attach portion. However, with this structure, an electromagnetic coupling occurs between the wiring and the die-attach portion on the piezoelectric substrate of the su acoustic wave filter element, such that the filter characteristics thereof deteriorate. In addition, it is necessary to adjust the position and the number of bumps to fix and electrically connect the surface acoustic wave filter element and the package in order to provide an inductance component in the die portion. However, since the position and the number of bumps do not necessarily achieve the sufficient electrical connections and mechanical bonding, the reliability of surface acoustic wave filter device deteriorates.

### SUMMARY OF THE INVENTION

[0018] In order to overcome the above-described problems, preferred embodiments of the present invention provide a surface acoustic wave filter device having excellent filter characteristics, in whic surface acoustic wave filter element including a ladder type circuit is accommodated in a package by face down mounting process. Inductances are added to parallel arm resonators and/or series arm resonators, and the deterioration of filter characteristics by the electromagnetic coupling between the electrodes on the surface acoustic wave filter element and the inductances provided in the package is prevented.

[0019] In accordance with a preferred embodiment of the present invention, a surface acoustic wave device includes a surface acoustic wave filter element including a piezoelectric substrate and a plura one terminal pair surface acoustic wave elements provided on the piezoelectric substrate, and in which one terminal pair surface acoustic wave elements are connected to define a parallel arm resonator an series arm resonator in a ladder circuit, and a package accommodating the surface acoustic wave filter element. In this surface acoustic wave filter device, the surface acoustic wave filter element is bonder plurality of bumps by using the face down mounting process and is accommodated in the package. It surface acoustic wave filter device further includes an inductance component of a microstrip line who provided in the package and connected to at least one of the series arm resonator and the parallel arm resonator.

[0020] In accordance with another preferred embodiment of the present invention, the above-describ package includes a die-attach portion including a plurality of electrode pads which are connected via bumps to one of a signal terminal and a ground terminal of the surface acoustic wave filter element, plurality of external electrodes which are electrically connected to at least one of the electrode pads, connected to one of a signal line and a ground line outside the surface acoustic wave filter device.

[0021] In accordance with another preferred embodiment of the present invention, the above-describ microstrip line is preferably connected between the electrode pad connected to the signal terminal of series arm resonator and the external electrode connected to the signal line outside the surface acous wave filter device.

[0022] In accordance with another preferred embodiment of the present invention, the above-describ microstrip line is provided between the electrode pad connected to the ground terminal of at least on parallel arm resonator via the bumps, and the external electrode which is connected to the ground lin outside the package.

[0023] In accordance with another preferred embodiment of the present invention, the surface acoust wave filter device includes at least two parallel arm resonators. In this surface acoustic wave filter de the ground terminals of all the parallel arm resonators are commonly connected on the piezoelectric substrate, and the microstrip line is connected between the portion where the ground terminals of the parallel arm resonators are commonly connected and the external electrode provided in the package. [0024] In accordance with still another preferred embodiment of the present invention, the surface as wave filter device includes at least two parallel arm resonators. In this surface acoustic wave filter dethe package-side electrode pads connected to the ground terminals of all the parallel arm resonators a common electrode pad, and the microstrip line is provided on the path between the common electropad and the external electrode.

[0025] In accordance with still another preferred embodiment of the present invention, the surface at wave filter device includes at least three parallel arm resonators, and an electrode land which is prov on the piezoelectric substrate, and to which the ground terminals of at least two parallel arm resonate each connected. In this surface acoustic wave filter device, the microstrip line is provided on the path between the electrode land connected to the ground terminals of at least two parallel arm resonators the external electrode to which the electrode land is connected, and the parallel arm resonator other the above-described at least two parallel arm resonators is electrically isolated from the above-describeat two parallel arm resonators on the piezoelectric substrate, and is electrically connected to the electrode other than the package-side external electrode connected to the above-described at least two parallel arm resonators.

[0026] In accordance with a further preferred embodiment of the present invention, the surface acou wave filter device includes at least three parallel arm resonators. In this surface acoustic wave filter of the plurality of electrode pads include a common electrode pad connected to the ground terminals of least two parallel arm resonators among the parallel arm resonators, and the microstrip line is provid the path between the common electrode pad and the external electrode to which the common electrodis connected, and the parallel arm resonator other than the above-described at least two parallel arm resonators is electrically isolated from the above-described at least two parallel arm resonators, at a cattach portion including the plurality of electrode pads, and is electrically connected to the external electrode other than the package-side external electrode connected to the above-described at least two parallel arm resonators.

[0027] In accordance with a further preferred embodiment of the present invention, the above-descri microstrip line is disposed in the package at the position other than the position of the die-attach port [0028] In accordance with a yet further preferred embodiment of the present invention, the above-described package includes a base board on which the surface acoustic wave filter element is mount annular side wall provided on the base board, and a cap member attached to the annual side wall so a close the upper end thereof. Herein, a main portion of the microstrip line is disposed between the sid and the base board.

[0029] In accordance with another preferred embodiment of the present invention, the above-describ package includes a first case member on which the surface acoustic wave filter element is mounted, second case member enclosing the surface acoustic wave filter element mounted on the first case me Herein, a main portion of the microstrip line is provided inside the first case member.

[0030] Here, "a main portion of a microstrip line" refers to at least 50% of the entire length of a microstrip line.

[0031] In accordance with still another preferred embodiment of the present invention, the signal ter at the input/output end of the surface acoustic wave filter element and at least one ground terminal the are arranged so as to be rotated by approximately 90[deg.] with respect to the imaginary line which the approximate center of the piezoelectric substrate of the surface acoustic wave filter element, and is substantially perpendicular to the piezoelectric substrate, with respect to the external electrode cort to the signal line at the input/output end and the external electrode connected to at least one ground potential among the plurality of external electrodes.

[0032] The communication device in accordance with another preferred embodiment of the present invention includes a surface acoustic wave filter device in accordance with the present invention. [0033] Other features, elements, characteristics and advantages of the present invention will become apparent from the following detailed description of preferred embodiments thereof with reference to attached drawings.

### BRIEF DESCRIPTION OF THE DRAWINGS

[0034] FIG. 1 is a schematic sectional view of a surface acoustic wave filter device in accordance wi first preferred embodiment of the present invention.

[0035] FIG. 2 is a plan view showing an electrode structure of a surface acoustic wave filter element in the surface acoustic wave filter device in accordance with the first preferred embodiment of the prinvention.

[0036] FIG. 3 is a schematic plan view showing a die-attach portion including a plurality of electrod on the top surface of a base board in a package of the surface acoustic wave filter device in accordan

with the first preferred embodiment of the present invention.

[0037] FIG. 4 is a circuit diagram of the surface acoustic wave filter device in accordance with the fi preferred embodiment of the present invention.

[0038] FIG. 5 is a plan view showing an electrode pattern on the top surface of the base board in the package of a conventional surface acoustic wave filter device prepared for comparison.

[0039] FIG. 6 is a diagram showing the attenuation value-frequency characteristics relationships in t surface acoustic wave device of the first preferred embodiment of the present invention and that of tl conventional example.

[0040] FIG. 7 is a circuit diagram of a surface acoustic wave filter device in accordance with a secor preferred embodiment of the present invention.

[0041] FIG. 8 is a plan view showing an electrode structure on the top surface of a base board in a pa used in a surface acoustic wave filter device in accordance with the second preferred embodiment of present invention.

[0042] FIG. 9 is a diagram showing the attenuation value-frequency characteristics relationships in t surface acoustic wave filter device of the second preferred embodiment of the present invention and the conventional example.

[0043] FIG. 10 is a circuit diagram of a surface acoustic wave filter device in accordance with a thire preferred embodiment of the present invention.

[0044] FIG. 11 is a plan view showing an electrode structure on the top surface of a base board in a package used in a surface acoustic wave filter device in accordance with the third preferred embodin the present invention.

[0045] FIG. 12 is a diagram showing the attenuation value-frequency characteristics relationships in surface acoustic wave filter device of the third preferred embodiment f the present invention and that conventional example.

[0046] FIG. 13 is a circuit diagram of a surface acoustic wave filter device in accordance with a four preferred embodiment of the present invention.

[0047] FIG. 14 is a schematic sectional view of a surface acoustic wave filter device in accordance v the fourth preferred embodiment of the present invention.

[0048] FIG. 15 is a plan view showing an electrode structure on the top surface of a base board in a package used in a surface acoustic wave filter device in accordance with the fourth preferred embodi of the present invention.

[0049] FIG. 16 is a plan view showing the electrode structure within the base board in the package u the surface acoustic wave filter device in accordance with the fourth preferred embodiment of the pre

[0050] FIG. 17 is a diagram showing the attenuation value-frequency characteristics relationships in surface acoustic wave filter device of the fourth preferred embodiment and that of the conventional

[0051] FIG. 18 is a circuit diagram showing an example of a surface acoustic wave filter device havi conventional ladder type circuit.

[0052] FIG. 19 is a sectional view showing another example of a conventional surface acoustic wave device.

### DETAILED DESCRIPTION OF PREFERRED EMBODIMENTS

[0053] Hereinafter, the surface acoustic wave filter device according to preferred embodiments of th present invention will be described in detail with reference to the drawings.

[0054] As shown in FIG. 1, the surface acoustic wave filter device 1 in accordance with a first prefer embodiment includes a package 2, and a surface acoustic wave filter element 3 accommodated in a package 2. FIG. 1 only schematically shows the appearance of the surface acoustic wave filter device [0055] The package 2 includes a base board 4 having a substantially rectangular plate shape, a substantially rectangular frame-shaped side wall 5 bonded on the base board 4, and a substantially rectangular plate-shaped cap member 6 affixed to the side wall 5 so as to close the upper opening the Alternatively, the side wall 5 may have a ring-shaped structure such as a substantially annular shape [0056] The base board 4 and the side wall 5 are preferably made of an insulative ceramic such as alu or a synthetic resin, or other suitable material. The cap member 6 is also preferably made of an insul

ceramic material. Alternatively, the cap member 6 may be made of a metal or other suitable having a electromagnetic shielding property.

[0057] The base board 4 is defined by a multilayer substrate including substrates 4b and 4c. Between substrate 4a and the substrate 4b, a ground electrode 50 defining a microstrip line which is described is provided on substantially an entire surface of the substrate 4b. The substrates 4b and 4c are prefer made of insulative material and have a desired dielectric constant.

[0058] As shown in FIG. 2, the surface acoustic wave filter element 3 includes a substantially rectan plate-shaped piezoelectric substrate 7. In this preferred embodiment, the piezoelectric substrate 7 is preferably made of a 36[deg.], Y-cut, and X-propagation LiTaO3 substrate. The piezoelectric substrate however, may be made of another piezoelectric single crystal, or a piezoelectric ceramic such as lead titanate zirconate-based ceramic. Alternatively, a piezoelectric substrate including a piezoelectric thi made of ZnO or other suitable material provided on a piezoelectric plate or an insulating substrate mused.

[0059] A metallic film is provided over the entire top surface 7a of the piezoelectric substrate 7, and an electrode pattern shown in the figure is formed from the metallic film by photolithography and et or other suitable process. A metallic material for forming the electrode pattern is not particularly lim but in this preferred embodiment, aluminum is used as a metallic material. The formation of an elect may also be performed using the lithography and lift off method.

[0060] The above-described electrode pattern will be described with reference to FIG. 2.

[0061] On the top surface 7a of the piezoelectric substrate 7, in order to define a ladder circuit, series resonators 8 and 9 and parallel arm resonators 10 to 12 each of which includes one terminal pair surface acoustic wave element are provided. Each of the series arm resonators 8 and 9 and the parallel arm resonators 10 to 12 includes one IDT and reflectors disposed on opposite sides of each the IDTs in the propagation direction of a surface acoustic wave. Referring to the series arm resonator 8 as a represe example, the series arm resonator 8 includes an IDT 8a and a pair of reflectors 8b and 8c.

[0062] Also, on the top surface 7a of the piezoelectric substrate 7, electrode lands 13 to 17 are provided Each of the electrode lands 13 to 17 defines a portion for electrically connecting the surface acoustic filter element 3 to the outside, and is formed of a metallic film having a desired area. Here, the substantially circular portions of the electrode lands 13 to 17 define the portions to be bonded by but [0063] The electrode land 13 defines the input end of the surface acoustic wave filter element 3, and connected to one end of the first series arm resonator 8 via a conductive path 18. The conductive pat electrically connects the electrode land 13, the one end of the series arm resonator 8, and one end of first parallel arm resonator 10. An end of the parallel arm resonator 10 which is opposite to the end t connected to the conductive path 18 is connected to the electrode land 14 via a conductive path 19. I electrode land 14 is connected to the ground potential.

[0064] Also, an end of the series arm resonator 8 which is opposite to the end thereof connected to the conductive path 18 is connected to a conductive path 20. The conductive path 20 is connected to one of the second series arm resonator 9 and also to one end of the second parallel arm resonator 11. An the second parallel arm resonator 11 which is opposite to the end thereof connected to the conductive 20 is connected to an electrode land 15. The electrode land 15 is connected to the ground potential. [0065] A conductive path 21 is connected to the other end of the second series arm resonator 9. The conductive path 21 is also connected to the electrode land 17 and one end of the third parallel arm resonator 12. The electrode land 17 is used as an output terminal. An end of the parallel arm resonator which is opposite to the end thereof connected to the conductive path 21 is connected to an electrode 16 via a conductive path 22. The electrode land 16 is connected to the ground potential.

[0066] In the surface acoustic wave filter element 3, therefore, the above-described first and second arm resonators 8 and 9, and the first to third parallel arm resonators are connected so as to define a 12 circuit shown in FIG. 4. Meanwhile, inductances L1 to L5 in FIG. 4 will be described later.

[0067] FIG. 3 illustrates the electrode structure provided on the top surface of the base board 4 in the package 2 shown in FIG. 1.

[0068] The surface acoustic wave filter element 3 is mounted on a portion indicated by a broken line the top surface 4a of the base board 4. At this portion, the above-described surface acoustic wave filt element 3 is bonded by bumps such that the top surface 7a of the piezoelectric substrate 7 is arranged down. More specifically, the surface acoustic wave filter element 3 shown in FIG. 2 is superimposed the top surface 4a of the base board 4 shown in FIG. 3, such that the top surface 7a of the piezoelectric substrate 7 is arranged to the piezoelectric substrate 7 is arranged to the surface 4a of the base board 4 shown in FIG. 3, such that the top surface 7a of the piezoelectric substrate 7 is arranged to the piezoelectric substrate 7 is a piezoelectric substrate 7 is arranged to the piezoelectric substrate 7 is arrange

substrate 7 is arranged face down, and the surface acoustic wave filter element 3 and the base board bonded by bumps, thereby fixing the surface acoustic wave filter element 3.

[0069] On the top surface 4a of the base board 4, the electrodes shown in the figure are preferably fc by printing and firing electrode paste. The plurality of electrode pads 23 to 27 define a die-attach por The electrode pads 23 to 27 are provided separately from one another. Among these, the electrode pais electrically connected to the electrode land 13 shown in FIG. 2 and mechanically bonded thereto v bump 28. Likewise, the electrode pads 24 to 26 are connected to the electrode lands 14 to 16 shown FIG. 2, respectively, via bumps 29, 30, and 31. Also, the electrode pad 27 is electrically connected to electrode land 17 shown in FIG. 2 via a bump 32.

[0070] Among the above-described electrode pads 23 to 27, the electrode pads 23 and 27 are each connected to an external signal line, while the electrode pad 24 and 26 are each connected to an exte ground line.

[0071] External electrodes 41 to 44 are provided on the top surface of the base board 4. The external electrodes 41 to 44 are provided not only on the top surface 4a of the base board 4, but also to extend bottom surface and the side surfaces thereof, at portions which are not shown in FIG. 1. Thus, each a external electrodes 41 to 44 electrically connecting the surface acoustic wave filter device 1 to the or [0072] The external electrode 44 is connected to the electrode pad 23 via a microstrip line 45. Likew the external electrode 41 is connected to the electrode pad 27 via a microstrip line 46. Also, the external electrode 42 is connected to the electrode pad 24 via a microstrip line 47, and the external electrode connected to both electrode pads 25 and 26 via microstrip lines 48 and 49, respectively.

[0073] The external electrodes 42 and 43 are, therefore, each connected to an external ground line, we the external electrodes 41 and 44 are each connected to a signal line.

[0074] The above-described microstrip lines 45 to 49 are arranged opposite to the ground electrode 5 the substrate 4b, as indicated by broken line in FIG. 3. Fine belt-shaped conductive patterns function microstrip lines. In FIG. 3, although the ground electrode 50 is provided on a substantially entire sur the substrate 4b, ground electrode 50 may be provided at portions opposite to the microstrip lines 45. The above-described microstrip lines 45 to 49 are located between the base board 4 and the side wal [0075]. In this preferred embodiment, inductance components are defined by the above-described microstrip lines 45 to 49. Specifically, an inductance L1 shown in FIG. 4 is defined by the microstrip 45, an inductance L2 is defined by the microstrip lines 47 to 49, respectively.

[0076] In other words, inductance components of the microstrip lines 47 to 49 are each connected be parallel arm resonators having a ladder circuit and the external electrodes each connected to the grou line. Likewise, inductance components of the microstrip lines 46 and 45 are each connected between arm resonators and the external electrodes 41 and 44 each connected to the external signal line, respectively.

[0077] In this preferred embodiment, in the surface acoustic wave filter device having a ladder type circuit including two series arm resonators 8 and 9 and three parallel arm resonators 10 to 12, induct components are independently added into the parallel arm resonators 10 to 12 by the above-describe microstrip lines 47 to 49, respectively. This provides a greatly increased pass band width and a great increased attenuation value in the vicinity of pass band. This will be described based on specific experimentation.

[0078] The solid line in FIG. 6 shows the attenuation value-frequency characteristics relationship of surface acoustic wave filter device in accordance with the first preferred embodiment of the present invention, and the broken line shows that of a surface acoustic wave filter device prepared for compa [0079] The conventional surface acoustic wave filter device, the results of which are shown in FIG. The broken line, is the same as that of the above-described preferred embodiment except that the elect configuration on the top surface of the base board of the package has been provided as shown in FIG. That is, electrode pads 105 to 107 are provided on the top surface 104a of a base board 104. External electrodes 111 to 114 are provided at the four corners. The external electrodes 111 to 114 are arrange as to extend from the top surface to the bottom surface via the side surfaces thereof. These external electrodes correspond to the portions which are electrically connected to the outside. The external electrodes 112 and 113 are electrically connected to the electrode pads 105 and 106 via wide conduct paths 108 and 109, respectively.

[0080] Since ground electrodes are not provided on portions of the base board 104 which are opposit

the conductive paths 108 and 109, the conductive paths 108 and 109 do not function as microstrip line. An electrode pad 107 having a large area is directly connected to external electrodes 111 and 114. The electrode pad 107 is bonded via bumps to the electrode lands 14 to 16 of the surface acoustic wave for element 3 which are connected to the ground line, and the electrode pads 105 and 106 are the portion are connected to the respective electrode lands 13 and 17 each connected to a signal terminal.

[0081] Therefore, in the conventional surface acoustic wave filter device prepared for comparison, the are no microstrip lines independently provided between the parallel arm resonators 10 to 12 and the external electrodes 111 and 114 each connected to a ground line, therefore, inductance components of the provided therebetween.

[0082] Likewise, there are no microstrip lines connected between the series arm resonators 8 and 9 a external electrodes 112 and 113, respectively, on the package side, therefore, inductance components microstrip lines are not provided therebetween.

[0083] The specifications of the surface acoustic wave filter element 3 used in the above-described preferred embodiment and the conventional example are as follows:

[0084] The series arm resonators 8 and 9:

[0085] interdigital width of electrode fingers=17 [mu]m, number of pairs of electrodes in an IDT=10 number of electrode fingers in a reflector=100, and electrode finger pitch=0.99 [mu]m (wavelength of surface acoustic wave [lambda]=1.99 [mu]m).

[0086] The first and third parallel arm resonators 10 and 12:

[0087] interdigital width of electrode finger=50 [mu]m, number of pairs of electrodes in an IDT=40, number of electrode fingers in a reflector=100, and electrode finger pitch=1.04 [mu]m (wavelength of surface acoustic wave [lambda]=2.07 [mu]m).

[0088] The second parallel arm resonators 11:

[0089] interdigital width of electrode finger=52 [mu]m, number of pairs of electrodes in an IDT=90, number of electrode fingers in a reflector=100, and electrode finger pitch=1.04 [mu]m (wavelength of surface acoustic wave [lambda]=2.08 [mu]m).

[0090] In the present preferred embodiment, the inductance components by the microstrip lines 45 to disposed on the base board 4, are as follows:

[0091] Microstrip lines 45 and 46 . . . 0.8 nH

[0092] Microstrip lines 47 and 49 . . . 0.8 nH

[0093] Microstrip line 48 . . . 0.5 nH

[0094] As shown in FIG. 6, the width of the pass band corresponding to an attenuation value of 4 dE MHz for this preferred embodiment, in contrast to 78 MHz for the conventional example, that is, this preferred embodiment exhibits a wider pass band width than the conventional example. The attenuat pole in the vicinity of the pass band, in this preferred embodiment, is located at substantially the sam frequency as that in the conventional example. This is because common inductance component is presince the electrode pads of the die-attach portion connected to the ground potential are separated from another, in other words, since inductance components are independently added to the first to third pa arm resonators 10 to 12 by the above-described microstrip lines 47 to 49.

[0095] Furthermore, since the microstrip lines 45 to 49 for providing the above-described inductance components are located between the base board and the side wall, minimal electromagnetic coupling between each of the microstrip lines 45 to 49 and the surface acoustic wave filter element 3 occurs, se that superior filter characteristics are achieved. In addition, since the above-described microstrip line 49 are not provided in the die-attach portion, these microstrip lines do not impose any limitations on location and the number of bumps. This allows the surface acoustic wave filter element 3 to be bond the base board 4 with greatly increased bonding strength.

[0096] Changing the dielectric constant of the substrate 4b on which the microstrip lines are provide the distance between the microstrip lines and the ground electrode 50 makes it possible to design the inductance component per unit length of the microstrip line. Therefore, the inductance component necessary to improve the characteristics of surface acoustic wave filter are designed and included in surface acoustic wave filter via the inductance component of microstrip line. Further, since the micro line is resistant to outside influences, the inductance component of the microstrip line does not substantially change even if the surface acoustic wave filter element is attached to the base board by down process. Therefore a desired inductance component is added to the surface acoustic wave filter [0097] FIG. 7 is a diagram showing the circuit configuration of a surface acoustic wave filter device

accordance with a second preferred embodiment of the present invention.

[0098] In this preferred embodiment, a surface acoustic wave filter element 3 similar to that in accor with the first preferred embodiment, is provided. As shown in FIG. 7, two series arm resonators 8 an and three parallel arm resonators 10 to 12 are connected to one another so as to have a ladder circuit configuration.

[0099] As seen from FIG. 7, however, in this preferred embodiment, the ends of the three parallel ar resonators 10 to 12 connected to the ground potential are commonly connected, and inductances L6 are connected between this commonly connected portion and the external electrodes which are each connected to an external ground line. Here, the ends of the three parallel arm resonators 10 to 12 con to the ground potential, that is, the ground terminals are commonly connected on the piezoelectric substrate.

[0100] Each of the above-described inductances L6 and L7 is defined by a microstrip line provided i package.

[0101] FIG. 8 is a plan view showing the electrode structure on the top surface of the base board 54 package used in the second preferred embodiment of the present invention.

[0102] The second preferred embodiment is preferably constructed in the same manner as the first preferred embodiment except that the electrode structure on the top surface of the base board 54 of the second preferred embodiment differs from that in the first preferred embodiment. Hence, regarding the structure of the surface acoustic wave filter element 3 and other structures of the package 2, the description of the first preferred embodiment will be referred to.

[0103] In this preferred embodiment, the surface acoustic wave filter element 3 is bonded via bumps the face down process, such that the top surface 4a (see FIG. 2) of the piezoelectric substrate 4 is arraface down on the area surrounded by broken line X on the top surface of the base board 54.

[0104] A die-attach portion including electrode pads 55 to 57 is provided on the top surface 54a of the board 54. The electrode pads 55 and 56 are bonded to the electrode lands 13 and 17 shown in FIG. 2 bumps 55a and 56a, respectively. The electrode pad 57 is bonded to the electrode lands 14, 15, and 1 connected to the ground potentials shown in FIG. 2, via bumps 57a to 57d.

[0105] As in the first preferred embodiment, external electrodes 61 to 64 are provided at the corner portions of the base board 54. The external electrodes 61 to 64 are provided not only on the top surface of the base board 54, but also so as to extend to the bottom surface via the side surfaces thereof. The above-described electrode pads 55 and 56 are connected to the external electrodes 64 and 61 via mic lines 65 and 66, respectively. The electrode pad 57 is connected to the external electrodes 62 and 63 respective microstrip lines 67 and 68.

[0106] That is, the terminals of the three parallel arm resonators connected to the ground potential vi electrode pad 57 in the die-attach portion of the package 2 are commonly connected, and the electrode 57 is connected to different external electrodes 62 and 63 via the respective microstrip lines 67 and 6 [0107] The electrode lands 13 and 17 defining input/output signal terminals and the electrode lands 16 defining ground terminals on the piezoelectric substrate 4, are arranged so as to be rotated by approximately 90[deg.] with respect to the normal line passing the approximate center of the piezoel substrate 4, with respect to the external electrodes 61 and 64 each connected to the signal line and the external electrodes 62 and 63 each connected to the ground line outside the package.

[0108] Similar to the first preferred embodiment, the microstrip lines 65, 66, 67 and 68 are opposite ground electrode 50. Other elements of the second preferred embodiment are the same as those of th preferred embodiment.

[0109] The attenuation value-frequency characteristics relationship of the surface acoustic wave filte device in accordance with the second preferred embodiment is indicated by a solid line in FIG. 9. Fo comparison, the attenuation value-frequency characteristics relationship of the surface acoustic wave device in accordance with a conventional example prepared similar to the comparative example used first preferred embodiment, is indicated by a broken line.

[0110] In the second preferred embodiment, each of the inductance components provided by the mic lines 65 and 66 is about 0.8 nH, and each of the inductance components added by the microstrip line and 68 is about 0.3 nH.

[0111] Actually, however, a common inductance of about 0.1 nH is inserted, since the microstrip lin and 68 connected to the external electrodes 62 and 63, that are each connected to an external ground are connected in parallel with the external ground lines.

[0112] As shown in FIG. 9, in this preferred embodiment, since inductance components are provided package 2 via the above-described microstrip lines 65 to 68, the attenuation value in the vicinity of the band is greatly increased. The width of the pass band corresponding to an attenuation value of about is about 80 MHz for this preferred embodiment, in contrast to 78 MHz for the conventional example is, the pass band width is simultaneously increased in this preferred embodiment.

[0113] In this preferred embodiment also, since microstrip lines for adding inductances are provided between the base board 4 and the annular side wall 5, the electromagnetic coupling with the surface acoustic wave filter element is greatly reduced, thereby providing greatly improved filter characteris Furthermore, as in the case of the first preferred embodiment, in this preferred embodiment, since no microstrip lines are provided in the die-attach portion, there are no limitations on the position and the number of bumps. This enables the surface acoustic wave filter element 3 to be securely bonded to the board 4.

[0114] FIG. 10 is a diagram showing the circuit configuration of a surface acoustic wave filter devic accordance with a third preferred embodiment of the present invention. In the third preferred embod the surface acoustic wave filter element 3 is constructed in a similar manner as the first preferred embodiment, and two series arm resonators 8 and 9 and three parallel arm resonators 10 to 12 are connected to one another so as to define a ladder circuit.

[0115] In this preferred embodiment, the side wall and the cap member of the package 2 are construct a similar manner as those of the first preferred embodiment. The difference between the third and fir preferred embodiments is in the electrode structure provided on the base board 74, as shown in FIG. Hence, regarding elements other than the electrode structure on the base board 74, descriptions there be described with reference to the description of the first preferred embodiment.

[0116] On the top surface 74a of the base board 74, a plurality of electrode pads 75, 76, 77, and 78 a provided, and a die-attach portion is defined by the plurality of electrode pads 75 to 78. The portion indicated by a circle or circles inside each of the electrode pads 75 to 78 define the locations of the b when the surface acoustic wave filter element 3 is bonded via the face down mounting process.

[0117] External electrodes 81 to 84 are provided at the corners of the base board 74, in a similar mar the first preferred embodiment. The external electrodes 81 and 84 are each connected to a signal line are connected to the electrode pads 76 and 75 via microstrip lines 86 and 85. The electrode pads 77 are connected to the external electrode 82 and 83 which are each connected to a ground line, via mic lines 87 and 88.

[0118] Also, the electrode pad 75 is connected to the electrode lands 13 shown in FIG. 2 via a bump and the electrode pad 76 is connected to the electrode land 17 shown in FIG. 2 via a bump 76a. The electrode pad 77 is connected to the electrode lands 14 (FIG. 2) via bumps 77a and 77b, and the elect pad 78 is connected to the electrode lands 15 and 16 (see FIG. 2) via bumps 78a and 78b. Herein, greterminals of at least two parallel arm resonators may be connected to one electrode land. In other wo electrode lands connected to the ground potential, for example, the electrode lands 15 and 16 are def by a common land.

[0119] As shown in FIG. 10, therefore, the first parallel arm resonator 10 and the second and third resonators 11 and 12 are separated from each other in the die-attach portion. An inductance L7 defin the microstrip line 87 is provided between the first parallel arm resonator 10 and the external electro connected to an external ground line, and an inductance L8 defined by the microstrip line 88 is provibetween the second and third parallel arm resonators 11 and 12 and the external electrode 83 that is connected to a ground line.

[0120] The attenuation value-frequency characteristics relationship of the surface acoustic wave filte device in accordance with the third preferred embodiment is shown in FIG. 12 using a solid line. For comparison, the attenuation value-frequency characteristics relationship of the surface acoustic wave device in accordance with the conventional example prepared for comparison similar to the first pref embodiment, is shown in FIG. 12 using a broken line.

[0121] In this case, each of the inductance components by the microstrip lines 85 and 86 was about 0 and each of the inductance components defined by the microstrip lines 87 and 88 was about 0.3 nH. elements of this preferred embodiment are similar to those of the first preferred embodiment.

[0122] As shown in FIG. 12, in this preferred embodiment, the attenuation value in the vicinity of th band is significantly increased over the conventional example, since inductance components are proving the package 2 by the above-described microstrip lines 85 to 88. The width of the pass band

corresponding to an attenuation value of about 4 dB, is about 85 MHz for this preferred embodiment contrast to 78 MHz for the conventional example, that is, the width of the pass band is greatly increa this preferred embodiment.

[0123] As compared with the frequency characteristics (FIG. 9) of the second preferred embodiment this preferred embodiment, the frequency at the attenuation pole fr in the vicinity of the pass band is increased. Therefore, when an increase in the attenuation value in the frequency range nearer to the band is required, the surface acoustic wave filter device in accordance with the third preferred embo is more advantageous than that in accordance with the second preferred embodiment.

[0124] FIG. 13 is a diagram showing the circuit configuration of a surface acoustic wave filter devic accordance with a fourth preferred embodiment of the present invention. In the fourth preferred embodiment, the same surface acoustic wave filter element 3 in accordance with the first preferred embodiment is used, and first and second series arm resonators 8 and 9 and parallel arm resonators 1 12 are connected to one another so as to define a ladder circuit.

[0125] As shown in FIG. 14, a package 2 includes a base board 94 defining a first case member. Als second case member including a side wall 95 and a cap 96, is constructed as in the same manner as t the first preferred embodiment.

[0126] In this preferred embodiment, the base board 94 is constructed by a laminated ceramic board including substrates 94b, 94c and 94d, and within the base board 94, microstrip lines for adding inductances as described later are provided.

[0127] FIG. 15 is a plan view showing a top surface of the base board 94 and a top surface of the sul 94b, and FIG. 16 is a plan view showing a top surface of the substrate 94c where microstrip lines are provided.

[0128] As shown in FIG. 15, electrode pads 55 to 57 are provided on the top surface of the base boar in a similar manner as the base board in the second preferred embodiment shown in FIG. 8. In this preferred embodiment, however, no external electrode and microstrip line are provided on the top su of the base board 94, and instead, are provided inside the base substrate 94. Through hole electrodes 95d penetrating through the substrate 94b and extending to the bottom surface thereof are provided ε locations of the electrode pads 55 to 57. As shown in FIG. 16 the lower ends of the through hole elec 95a to 95d are connected to one-side end of the microstrip lines 97a to 97d provided on the upper su of the substrate 94c, respectively. The other ends of the microstrip lines 97a to 97d are connected to external electrodes 98a to 98d on the upper surface of the substrate 94c, respectively. The external electrodes 98a to 98d are arranged so as to extend from the corner portions to the bottom surface of t base board 94 to the side surfaces of the substrates 94c and 94d (see FIG. 14). Further, as indicated t broken line in FIG. 16, the ground electrode 50 for microstrip lines 97a to 97d is arranged to cover tl substantially entire bottom surface of the substrate 94c.

[0129] More specifically, in this preferred embodiment, the microstrip lines 97a to 97d are embedde the base board 94, and via these microstrip lines 97a to 97d, as shown in FIG. 13, inductance compo L9 and L10 are defined between the portion where the first to third parallel arm resonators are comm connected, and the external electrodes each connected to an external ground line, while inductance components L1 and L2 are defined between the series arm resonators 8 and 9 and the external electronic series arm resonators 8 and 9 and the external electronic series arm resonators 8 and 9 and the external electronic series arm resonators 8 and 9 and the external electronic series arm resonators 8 and 9 and the external electronic series arm resonators 8 and 9 and the external electronic series arm resonators 8 and 9 and the external electronic series arm resonators 8 and 9 and the external electronic series are series arm resonators 8 and 9 and the external electronic series are series and series are serie each connected to an external signal line.

[0130] In this manner, the microstrip lines for adding inductances can be provided at any location wi the package.

[0131] The solid line in FIG. 17 shows the attenuation value-frequency characteristics relationship o surface acoustic wave filter device in accordance with the fourth preferred embodiment, and the brol line shows the attenuation value-frequency characteristics relationship of the surface acoustic wave t device in accordance with the conventional example prepared for comparison. Here, in the surface a wave filter device in accordance with the fourth preferred embodiment, the inductance component de by a microstrip line included for each of the series arm resonators was about 1.0 nH, and the inducta components L9 and L10 each connected between the parallel arm resonator and the ground line was

[0132] As shown in FIG. 17, in this preferred embodiment, microstrip lines for adding inductance components greatly increases the attenuation value in the vicinity of the pass band. In particular, the improvement in the attenuation value on the lower frequency side is significant. This is because the frequency fr of the attenuation pole is reduced because the value of the inductances L8 and L9 conne in parallel with each other are increased.

[0133] In the fourth preferred embodiment, since the microstrip lines are embedded in the base board is, since the microstrip lines are provided as internal electrodes, each of the microstrip lines is length thereby providing an increased inductance value. In order to obtain an even larger inductance value, preferable to lengthen a microstrip line by providing a plurality of layers of microstrip lines, and electrically connecting the plurality of microstrip lines with one another via a through hole electrode via hole electrode.

[0134] As described above, in the surface acoustic wave filter device in accordance with preferred embodiments of the present invention, since inductance components defined by microstrip lines are connected to any of the series arm resonators and parallel arm resonators defining a ladder circuit, ar microstrip lines are arranged in the package, the attenuation value in the vicinity of the pass band is increased and wide-band filter characteristics are achieved.

[0135] Changing the dielectric constant of the substrate on which the microstrip lines are provided, & distance between the microstrip lines and the ground electrode makes it possible to design the induct component per unit length of the microstrip line. Therefore, inductance components necessary to imp the characteristics of surface acoustic wave filter are easily designed and provided in the surface aco wave filter via the microstrip line. Further, since the microstrip line is resistant to the influence from outside, the inductance component of the microstrip line is not substantially changes even when the acoustic wave filter clement is attached to the base board via the face down mounting process. There desired inductance component is added to the surface acoustic wave filter.

[0136] When the package includes a die-attach portion having a plurality of electrode pads each of v is connected to any one of the signal terminals and any one of the ground terminals of the surface ac wave filter element via bumps, and a plurality of external electrodes each of which is electrically connected to any one of the electrode pads, and each of which is connected to a signal line or a grow outside the surface acoustic wave filter device, the surface acoustic wave filter element is securely connected and mechanically bonded to the plurality of electrode pads using bumps via face down mounting process. The present invention, therefore, provides a wide-band filter device having a grea increased attenuation value outside the pass band.

[0137] When each of the microstrip lines is connected between the electrode pad connected to the significant to the significant of the microstrip lines is connected between the electrode pad connected to the significant of the microstrip lines is connected between the electrode pad connected to the significant of the microstrip lines is connected between the electrode pad connected to the significant of the microstrip lines is connected between the electrode pad connected to the significant of the microstrip lines is connected between the electrode pad connected to the significant of the microstrip lines is connected between the electrode pad connected to the significant of the microstrip lines is connected between the electrode pad connected to the significant of the significant o terminal of the series arm resonator and the external electrode connected to the signal line outside th surface acoustic wave filter device, since each of the microstrip lines is connected between the series resonator and the signal line, the reflection loss is greatly reduced and the width of the pass band is g increased.

[0138] When each of the above-described microstrip lines is provided between the electrode pad wh connected to the ground terminal of at least one parallel arm resonator via the bumps, and the extern electrode which is connected to the ground line outside the package, the increase in attenuation value vicinity of the pass band and wide-band filter characteristics are achieved.

[0139] When the surface acoustic wave filter device includes at least two parallel arm resonators, wh the ground terminals of all the parallel arm resonators are commonly connected, on the piezoelectric substrate, wherein each of the microstrip lines is connected between the portion where the ground terminals of the parallel arm resonators are commonly connected, and each of the external electrodes provided in the package, the attenuation value can be increased at lower frequency range.

[0140] Likewise, when the package-side electrode pads connected to the ground terminals of all the parallel arm resonators are defined by a common electrode pad, and each of the microstrip lines is pr on the path between the common electrode pad and each of the external electrodes, the attenuation v increased at lower frequency range, as well. In addition, defining the electrode pads as a common pa the package side facilitates the wiring of chips.

[0141] When the surface acoustic wave filter includes at least three parallel arm resonators, wherein microstrip lines are provided on the path between the electrode lands to which the ground terminals least two parallel arm resonators are connected, and the external electrodes to which these electrode are connected, and wherein the parallel arm resonators other than the above-described at least two parallel arm resonators other than the above-described at least two parallel arm resonators other than the above-described at least two parallel arm resonators other than the above-described at least two parallel arm resonators other than the above-described at least two parallel arm resonators other than the above-described at least two parallel arm resonators other than the above-described at least two parallel arm resonators other than the above-described at least two parallel arm resonators other than the above-described at least two parallel arm resonators other than the above-described at least two parallel arm resonators other than the above-described at least two parallel arm resonators other than the above-described at least two parallel arm resonators of the parallel arm resonato arm resonators are, on the piezoelectric substrate, electrically isolated from the above-described at le two parallel arm resonators, the width of the pass band is further increased while simultaneously incl the attenuation value in the vicinity of the pass band.

[0142] When the surface acoustic wave filter device includes at least three parallel arm resonators, a

common electrode pad connected to the ground terminals of at least two parallel arm resonators amo parallel arm resonators, wherein each of the microstrip lines is provided on the path between the con electrode pad and the external electrodes to which the common electrode pad is connected, and when other parallel arm resonators are electrically isolated from the above-described at least two parallel a resonators, at a die-attach portion including a plurality of electrode pads, the attenuation value in the vicinity of the pass band is further increased, and wideband filter characteristics are achieved.

[0143] When the microstrip lines are disposed, in the package, at the positions other than the position the die-attach portion, the electromagnetic interference with the surface acoustic wave filter element consequently, the deterioration of filter characteristics is prevented.

[0144] When the package includes a base board, an annular side wall provided on the base board, an cap member affixed to the annual side wall so as to close the upper end thereof, wherein the main pc of each of the microstrip lines is disposed between the side wall and the base board, no extra space is required, such that filter characteristics are greatly improved without increasing the size of the packa [0145] When the package includes the first case member on which the surface acoustic wave filter elies mounted, and the second case member enclosing the surface acoustic wave filter element mounted the first case member, wherein the main portion of each of the microstrip lines is provided inside the case member, large inductance components can be provided, resulting in significantly improved filte characteristics.

[0146] When the signal terminals at the input/output ends of the surface acoustic wave filter element least one ground terminal thereof are arranged so as to be rotated by 90[deg.] around the imaginary I which passes the approximate center of the piezoelectric substrate of the surface acoustic wave filter element, and which is substantially perpendicular to the piezoelectric substrate, with respect to the explication electrodes connected to the input/output end signal lines and at least one external electrode connecte the ground potential among the plurality of external electrodes, increased inductance components car provided without providing bending portions, when forming microstrip lines between the side wall a base board.

[0147] The surface acoustic wave filter device according to preferred embodiments of the present invention can be provided in various communication apparatuses and signal processing devices, in particular, small communication apparatuses such as portable phone.

[0148] While preferred embodiments of the invention have been described above, it is to be understorn that variations and modifications will be apparent to those skilled in the art without departing the score spirit of the invention. The scope of the invention, therefore, is to be determined solely by the follow claims.

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Claims of corresponding document: US2003058066

- 1. A surface acoustic wave filter device, comprising:
- a surface acoustic wave filter element including a piezoelectric substrate and a plurality of one termi pair surface acoustic wave elements provided on said piezoelectric substrate, said plurality of one termi pair surface acoustic wave elements being connected so as to define a parallel arm resonator and a se arm resonator in a ladder circuit; and
- a package accommodating said surface acoustic wave filter element;
- said surface acoustic wave filter element being bonded via a plurality of bumps by means of the face process and being accommodated in said package; and
- an inductance component of a microstrip line which is provided in said package and connected to at one of said series arm resonator and said parallel arm resonator.
- 2. A surface acoustic wave filter device in accordance with claim 1, wherein said package includes a attach portion including a plurality of electrode pads which are connected via said bumps to one of a terminal and a ground terminal of the surface acoustic wave filter element; and a plurality of externa electrodes which are electrically connected to at least one of said electrode pads, and connected to or

signal line and a ground line outside the surface acoustic wave filter device.

- 3. A surface acoustic wave filter device in accordance with claim 2, wherein said microstrip line is connected between said electrode pad connected to the signal terminal of said series arm resonator a external electrode connected to the signal line outside said surface acoustic wave filter device.
- 4. A surface acoustic wave filter device in accordance with claim 2 or 3, wherein said microstrip line provided between said electrode pad which is connected to the ground terminal of at least one paraller resonator via said bump, and said external electrode which is connected to the ground line outside the package.
- 5. A surface acoustic wave filter device in accordance with claim 2, comprising at least two said para arm resonators,

wherein the ground terminals of all said parallel arm resonators are commonly connected on said piezoelectric substrate; and

said microstrip line is connected between the portion where the ground terminals of said parallel arm resonators are commonly connected, and the external electrode provided in said package.

6. A surface acoustic wave filter device in accordance with claim 2, comprising at least two said pararm resonators,

wherein said package-side electrode pads connected to the ground terminals of all said parallel arm resonators are made a common electrode pad; and

said microstrip line is provided on the path between said common electrode pad and said external electrode.

7. A surface acoustic wave filter device in accordance with claim 2, comprising:

at least three said parallel arm resonators; and

an electrode land which is provided on said piezoelectric substrate, and to which the ground terminal least two parallel arm resonators are connected,

wherein said microstrip line is provided on the path between said electrode land connected to the grc terminals of at least two parallel arm resonators and said external electrode to which said electrode is connected; and

the parallel arm resonator other than said at least two parallel arm resonators is electrically isolated f said at least two parallel arm resonators on the piezoelectric substrate, and is electrically connected t external electrode other than the package-side external electrode connected to said at least two parall resonators.

8. A surface acoustic wave filter device in accordance with claim 2, comprising at least three said pa arm resonators,

wherein said plurality of electrode pads include a common electrode pad connected to the ground ter of at least two parallel arm resonators among said parallel arm resonators, and wherein said microstr is provided on the path between the common electrode pad and the external electrode to which said common electrode pad is connected; and

the parallel arm resonator other than said at least two parallel arm resonators is electrically isolated f said at least two parallel arm resonators, at a die-attach portion including said plurality of electrode t and is electrically connected to the external electrode other than the package-side external electrode connected to said at least two parallel arm resonators.

- 9. A surface acoustic wave filter device in accordance with any one of claims 1 to 8, wherein said microstrip line is disposed in the package at the position other than the position of said die-attach po
- 10. A surface acoustic wave filter device in accordance with any one of claims 1 to 9, wherein said package includes a base board on which said surface acoustic wave filter element is mounted; an anr side wall provided on said base board; and a cap member attached to said annual side wall so as to conthe upper end thereof,

wherein a main portion of said microstrip line is disposed between said side wall and said base board

- 11. A surface acoustic wave filter device in accordance with any one of claims 1 to 9, wherein said package includes a first case member on which said surface acoustic wave filter element is mounted; second case member enclosing the surface acoustic wave filter element mounted on the first case me wherein a main portion of said microstrip line is provided inside said first case member.
- 12. A surface acoustic wave filter device in accordance with any one of claims 1 to 11, wherein the sterminal at the input/output end of said surface acoustic wave filter element and at least one ground terminal thereof are arranged so as to be rotated by 90[deg.] about the imaginary line which passes the center of the piezoelectric substrate of said surface acoustic wave filter element, and which is perpendicular to the piezoelectric substrate, with respect to the external electrode connected to the siline at the input/output end and the external electrode connected to at least one ground potential amo said plurality of external electrodes.
- 13. A communication device comprising a surface acoustic wave filter device in accordance with an of claims 1 to 12.

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